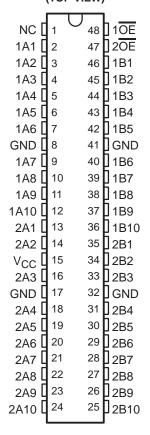
- Member of Texas Instruments' Widebus™
  Family
- 5-Ω Switch Connection Between Two Ports
- TTL-Compatible Input Levels

#### description

The SN74CBT16210 provides 20 bits of high-speed TTL-compatible bus switching. The low on-state resistance of the switch allows connections to be made with minimal propagation delay.

The device is organized as a dual 10-bit bus switch with separate output-enable  $(\overline{OE})$  inputs. It can be used as two 10-bit bus switches or as one 20-bit bus switch. When  $\overline{OE}$  is low, the associated 10-bit bus switch is on, and port A is connected to port B. When  $\overline{OE}$  is high, the switch is open, and the high-impedance state exists between the ports.

# DGG, DGV, OR DL PACKAGE (TOP VIEW)



NC - No internal connection

#### ORDERING INFORMATION

TA	PACKAGE <sup>†</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING	
-40°C to 85°C	SSOP – DL	Tube	SN74CBT16210DL	CBT16210	
		Tape and reel	SN74CBT616210DLR	CB110210	
	TSSOP – DGG	Tape and reel	SN74CBT16210DGGR	CBT16210	
	TVSOP – DGV	Tape and reel	SN74CBT16210DGVR	CY210	

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

## FUNCTION TABLE (each 10-bit bus switch)

INPUT OE	FUNCTION			
L	A port = B port			
Н	Disconnect			

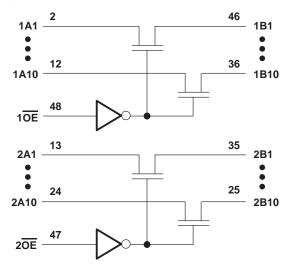


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### logic diagram (positive logic)



### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>		-0.5	V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)		-0.5	$V$ to $7\ V$
Continuous channel current			128 mA
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)			-50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 2):	DGG package		70°C/W
-	DGV package		58°C/W
	DL package		63°C/W
Storage temperature range, T <sub>stq</sub>	—6	5°C t	o 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### recommended operating conditions (see Note 3)

		MIN	MAX	UNIT
VCC	Supply voltage	4	5.5	V
VIH	High-level control input voltage	2		V
V <sub>IL</sub>	Low-level control input voltage		0.8	V
TA	Operating free-air temperature	-40	85	°C

NOTE 3: All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

<sup>2.</sup> The package thermal impedance is calculated in accordance with JESD 51-7.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS			MIN	TYP†	MAX	UNIT	
VIK		$V_{CC} = 4.5 \text{ V},$	I <sub>I</sub> = -18 mA				-1.2	V	
Ц		$V_{CC} = 0 V$ ,	V <sub>I</sub> = 5.5 V				10	μΑ	
		$V_{CC} = 5.5 \text{ V},$	$V_I = 5.5 \text{ V or GND}$				±1		
Icc		$V_{CC} = 5.5 \text{ V},$	$I_{O} = 0$ ,	$V_I = V_{CC}$ or GND			3	μΑ	
Δlcc <sup>‡</sup>	Control inputs	$V_{CC} = 5.5 \text{ V},$	One input at 3.4 V,	Other inputs at V <sub>CC</sub> or GND			2.5	mA	
Ci	Control inputs	V <sub>I</sub> = 3 V or 0				4.5		pF	
C <sub>io(OFF)</sub>		$V_0 = 3 \text{ V or } 0,$	OE = V <sub>CC</sub>			5.5		pF	
r <sub>on</sub> §		$V_{CC} = 4 \text{ V},$ TYP at $V_{CC} = 4 \text{ V}$	V <sub>I</sub> = 2.4 V,	I <sub>I</sub> = 15 mA		14	20		
			V <sub>I</sub> = 0	I <sub>I</sub> = 64 mA		5	7	Ω	
		$V_{CC} = 4.5 \text{ V}$	I <sub>I</sub> = 30 mA		5	7			
			V <sub>I</sub> = 2.4 V,	I <sub>I</sub> = 15 mA		8	12		

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC}$  = 5 V (unless otherwise noted),  $T_A$  = 25°C.

# switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

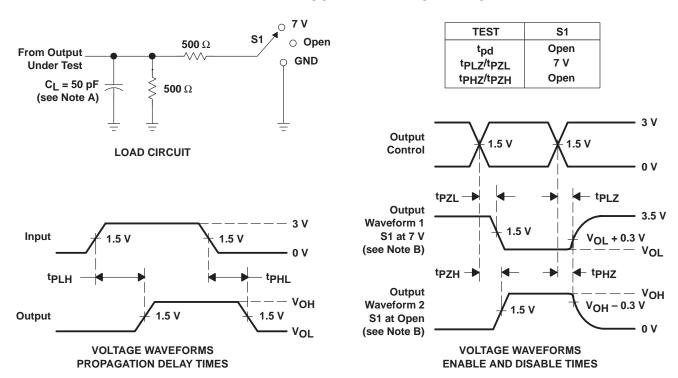
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 4 V		V <sub>CC</sub> = 5 V ± 0.5 V		UNIT
			MIN	MAX	MIN	MAX	
t <sub>pd</sub> ¶	A or B	B or A		0.35		0.25	ns
t <sub>en</sub>	ŌĒ	A or B		9.3	3.3	8.6	ns
t <sub>dis</sub>	ŌĒ	A or B		7.1	2.8	7.9	ns

The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

<sup>‡</sup> This is the increase in supply current for each input that is at the specified TTL voltage level rather than V<sub>CC</sub> or GND.

<sup>§</sup> Measured by the voltage drop between the A and B terminals at the indicated current through the switch. On-state resistance is determined by the lowest voltage of the two (A or B) terminals.

#### PARAMETER MEASUREMENT INFORMATION



- NOTES: A. C<sub>I</sub> includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_f \leq$  2.5 ns,  $t_f \leq$  2.5 ns.
  - D. The outputs are measured one at a time with one transition per measurement.
  - E. tpLz and tpHz are the same as tdis.
  - F. tpzL and tpzH are the same as ten.
  - G. tplH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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